

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/092,225	BOETTCHER, JENS	
Examiner		Art Unit		Page 1 of 1
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B	US-4,989,133	01-1991	May et al.	718/102
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**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
U	David B. Stewart, Measuring Execution Time and Real - Time Performance, Embedded Research Solutions, LLC., Embedded Systems Conference San Francisco, CA, April 2001		
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.